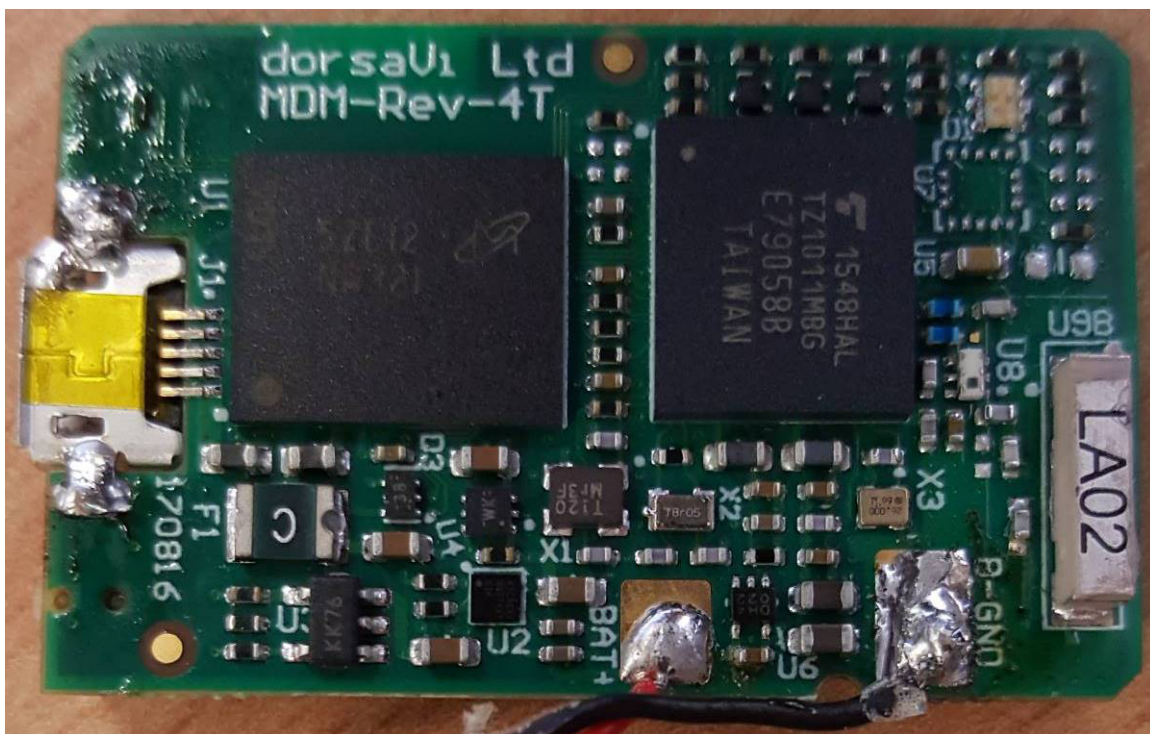
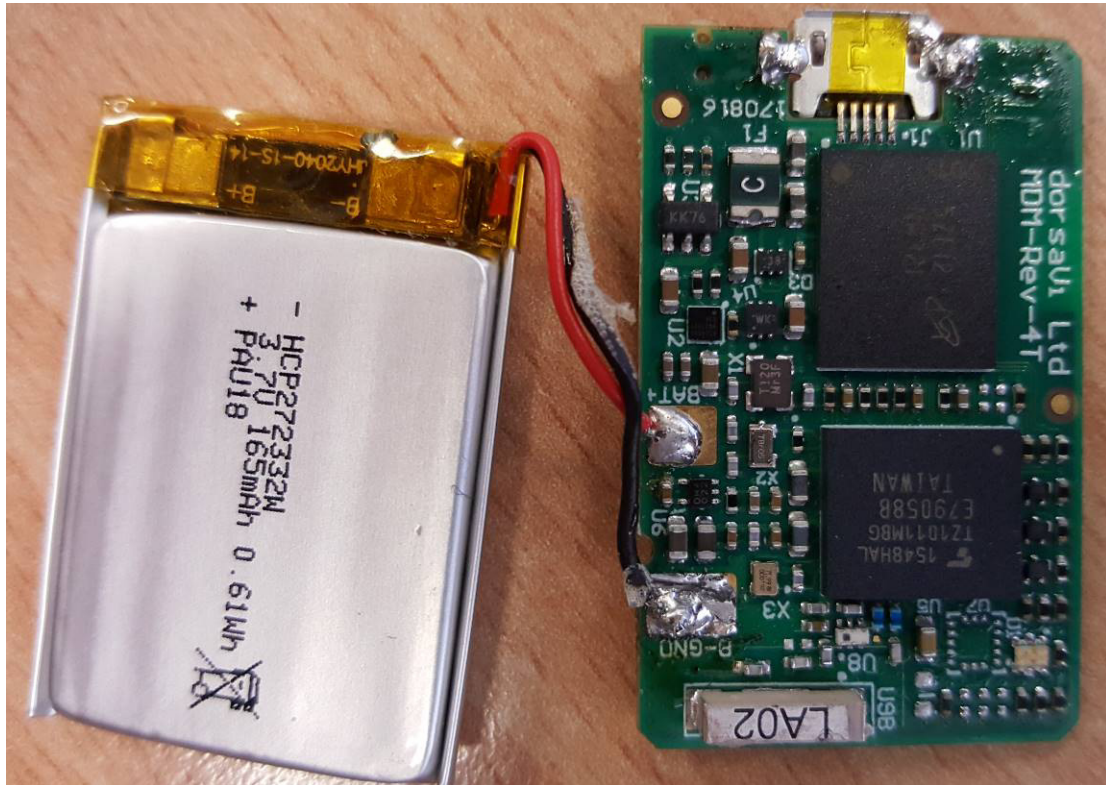
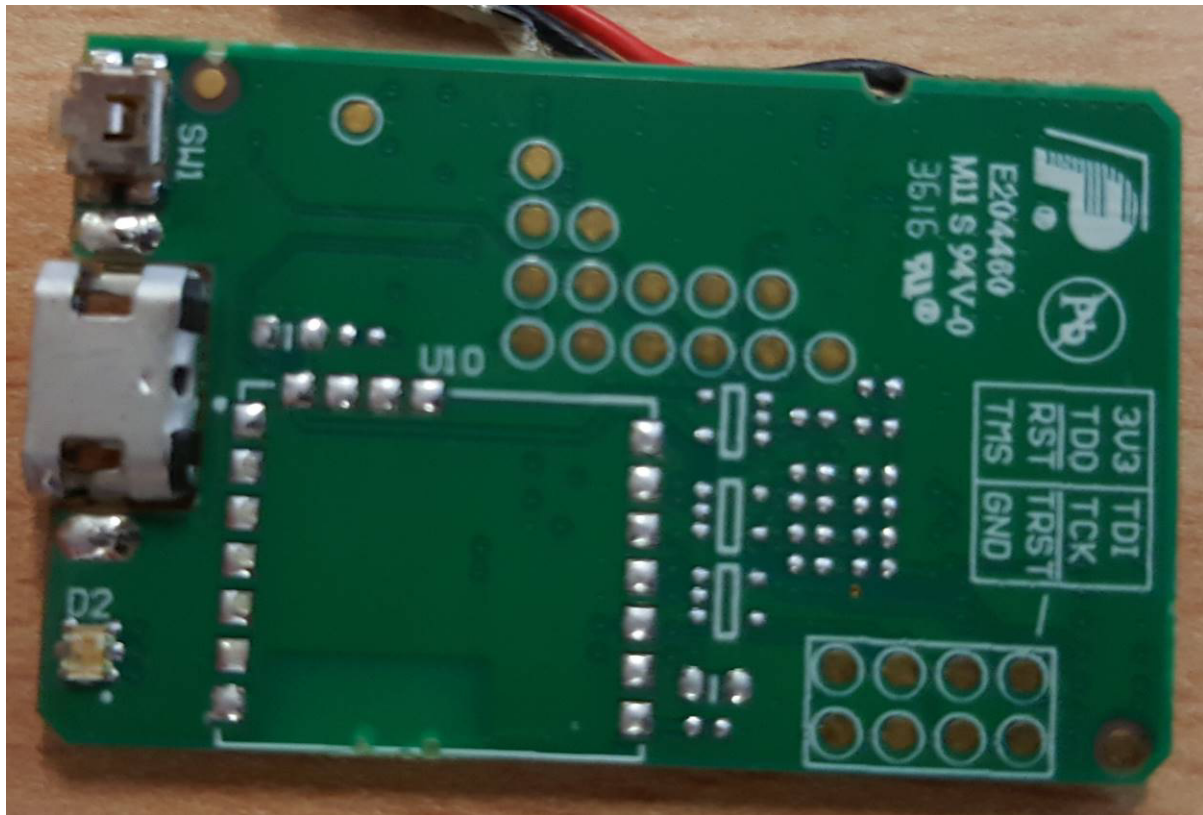


Test Sample Internal Photographs

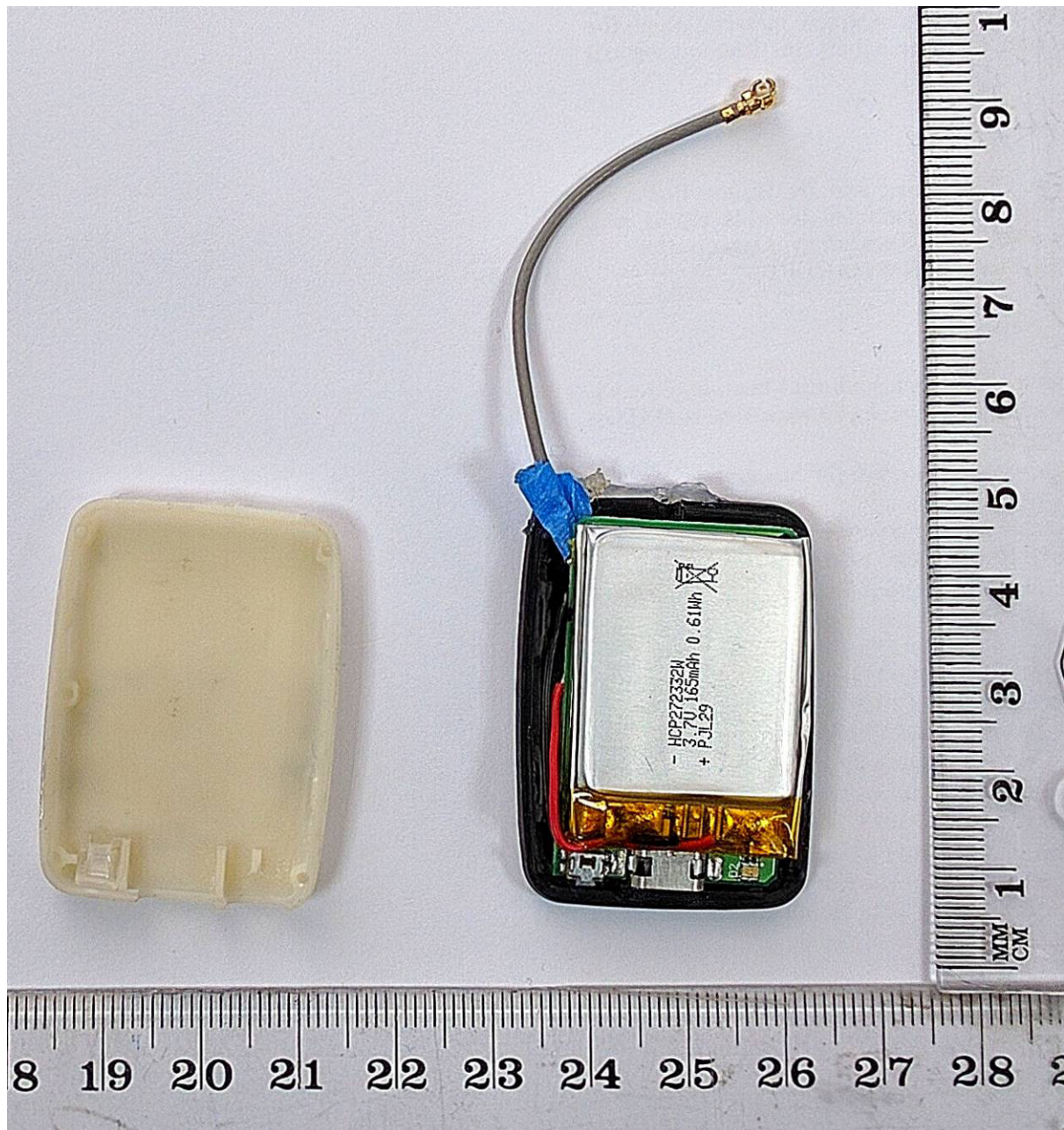
Internal view of sample with shield removed



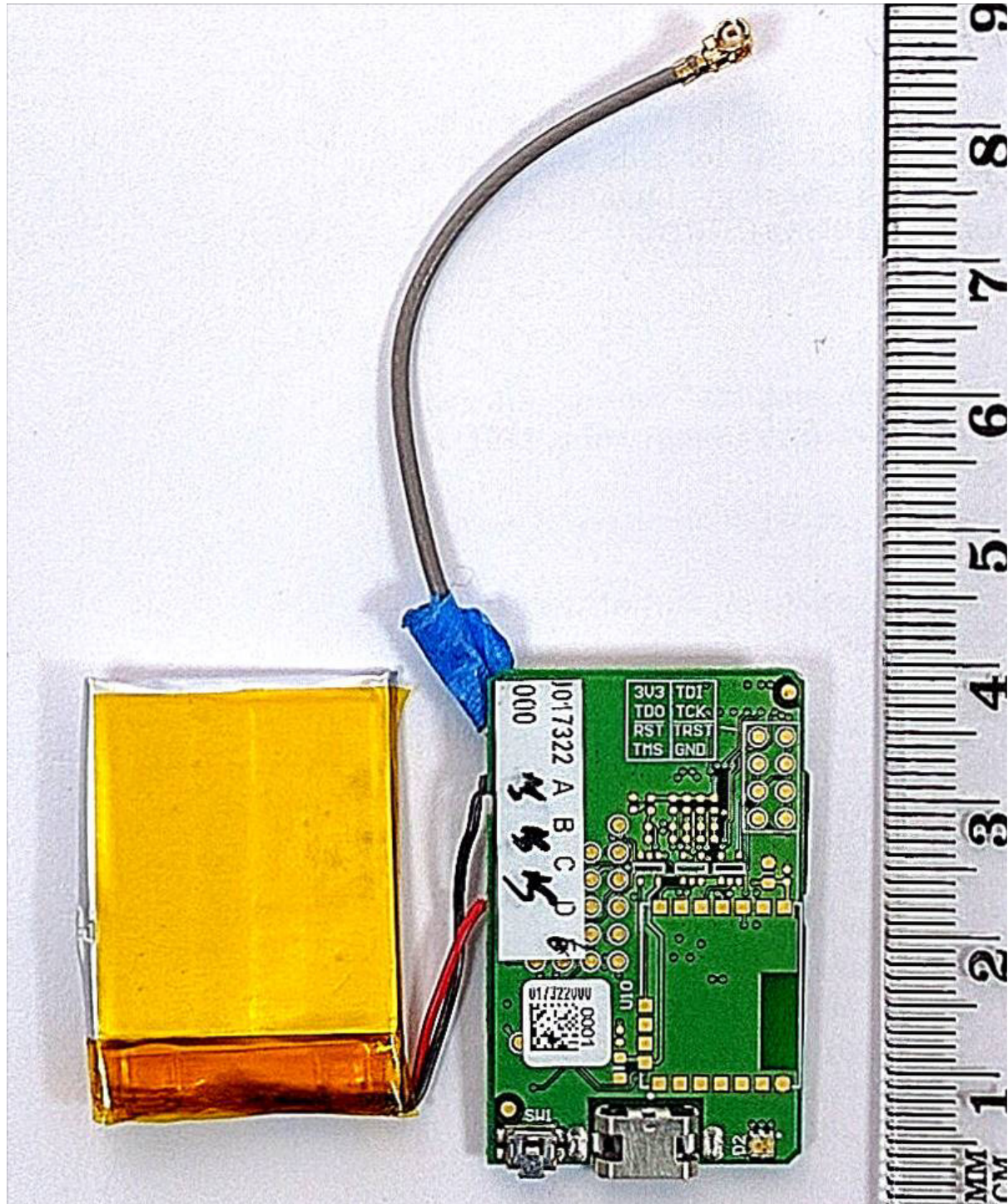
Internal view of sample, reverse side of PCB



Internal view of sample with temporary RF connector



Internal view of sample with temporary RF connector



Internal view of sample with temporary RF connector

